Gallium Nitride 28V 100W, RF Power Transistor

Description

The NX6010H is a 100W 28V, GaN HEMT, designed for multiple applications with frequencies up to 4GHz.

There is no guarantee of performance when this part is used in applications designed Outside of these frequencies.

It is also the dual-path version of single ended NU6006H.

 \bullet Typical performance (on Innogration narrow band fixture with device soldered) V_{DD} =28V I_{DQ} =600mA, CW.

| Frequency(MHz) | Gp (dB) | P _{sat} (W) | Efficiency (%) | |
|----------------|---------|----------------------|----------------|--|
| 1300 | 19 | 110 | 70 | |



Applications and Features

- Suitable for wireless communication infrastructure, wideband amplifier, EMC testing, ISM etc.
- High Efficiency and Linear Gain Operations
- Thermally Enhanced Industry Standard Package
- High Reliability Metallization Process
- Excellent thermal Stability and Excellent Ruggedness
- Compliant to Restriction of Hazardous Substances (RoHS) Directive 2002/95/EC

Important Note: Proper Biasing Sequence for GaN HEMT Transistors

Turning the device ON

- 1. Set VGS to the pinch—off (VP) voltage, typically -5 V
- 2. Turn on VDS to nominal supply voltage (28V)
- 3. Increase VGS until IDS current is attained
- 4. Apply RF input power to desired level

Turning the device OFF

- 1. Turn RF power off
- 2. Reduce VGS down to VP, typically -5 V
- 3. Reduce VDS down to 0 V
- 4. Turn off VGS

Table 1. Maximum Ratings (Not simultaneous, TC = 25°C unless otherwise noted)

| Rating | Symbol | Value | Unit |
|---|-----------------|-------------|------|
| Drain—Source Voltage | $V_{	t DSS}$ | 150 | Vdc |
| Gate—Source Voltage | V _{GS} | -10,+2 | Vdc |
| Operating Voltage | V_{DD} | 40 | Vdc |
| Maximum Forward Gate Current | Igmax | 28.8 | mA |
| Storage Temperature Range | Tstg | -65 to +150 | °C |
| Case Operating Temperature | Tc | +150 | °C |
| Operating Junction Temperature(See note 1) | TJ | +200 | °C |
| Total Device Power Dissipation (Derated above 25°C, see note 2) | Pdiss | 150 | W |

- 1. Continuous operation at maximum junction temperature will affect MTTF
- 2. Bias Conditions should also satisfy the following expression: Pdiss < (Tj Tc) / RJC and Tc = Tcase

NX6010H GaN TRANSISTOR

Table 2. Thermal Characteristics

| Characteristic | Symbol | Value | Unit | |
|--|----------|-------|------|--|
| Thermal Resistance, Junction to Case | Do to Do | 1.25 | CAM | |
| T _C = 85°C, T _J =200°C, DC Power Dissipation(See note 1) | Rejc-dc | 1.25 | C/W | |

ReJC-DC is tested at only DC condition, it is related to the highest thermal resistor value among all test conditions. It might be differently lower in different RF operation conditions like CW signal ,pulsed RF signal etc.

Table 3. Electrical Characteristics ($T_C = 25^{\circ}C$ unless otherwise noted)

DC Characteristics

| Characteristic | Conditions | Symbol | Min | Тур | Max | Unit |
|--------------------------------|--|----------------------|-----|------|-----|------|
| Drain-Source Breakdown Voltage | V _{GS} =-8V; I _{DS} =28.8mA | V _{DSS} | 150 | | | V |
| Gate Threshold Voltage | V _{DS} = 28V, I _D =28.8mA | V _{GS} (th) | | -2.7 | | V |
| Gate Quiescent Voltage | V _{DS} =28V, I _{DS} =600mA, Measured in Functional Test | V _{GS(Q)} | | -2.3 | | V |

Functional Tests (In Innogration narrow band Test Fixture, 50 ohm system) : V_{DD} = 28 Vdc, I_{DQ} = 600 mA, f = 1300 MHz, CW

| Characteristic | Symbol | Min | Тур | Max | Unit |
|--|------------------|-----|------|-----|------|
| Power Gain @ P _{sat} | Gp | | 19 | | dB |
| Drain Efficiency @ P _{sat} | Eff | | 70 | | % |
| Saturated Power | P _{sat} | | 110 | | W |
| Input Return Loss | IRL | | -7 | | dB |
| Mismatch stress at all phases (Device no damage) | VSWR | | 10:1 | | Ψ |

Loadpull data (half section only):

Test condition: (100us, 10% duty cycle), Vds=28V, Idq=150mA, Gain is defined as compressed gain at Pout

| NU6006H | Freq (MHz) | VDD (V) | ldq (mA) | Zsource (ohms) | Zload (ohms) | Pout (dBm) | Gain (dB) | Eff (%) |
|-----------|---------------|------------|-------------|-------------------|-----------------|---------------|--------------|------------|
| MXP | 1500 | 28 | 150 | 1.0+j*1.0 | 3.8-j*2.3 | 49.85 | 18.61 | 77.76 |
| MXE | 1500 | 28 | 150 | 1.0+j*1.0 | 5.3+j*1.2 | 48.07 | 20.17 | 86.01 |
| Trade Off | 1500 | 28 | 150 | 1.0+j*1.0 | 4.4-j*0.6 | 49.35 | 19.83 | 83.08 |

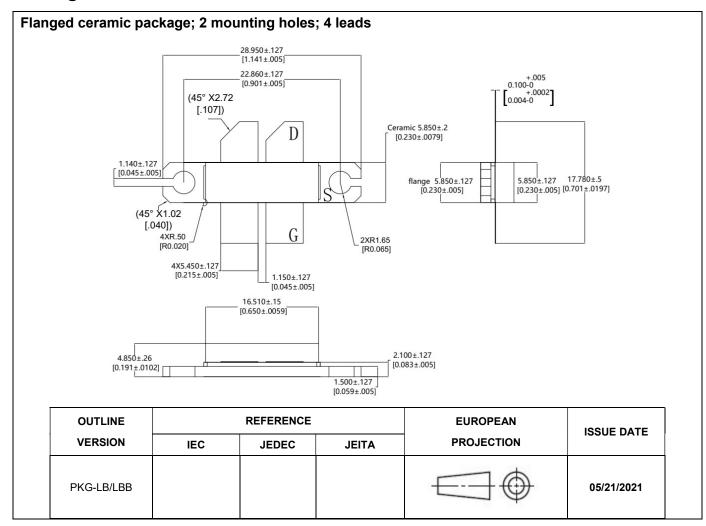
| NU6006H | Freq (MHz) | VDD (V) | ldq (mA) | Zsource (ohms) | Zload (ohms) | Pout (dBm) | Gain (dB) | Eff (%) |
|-----------|---------------|------------|-------------|-------------------|-----------------|---------------|--------------|------------|
| MXP | 2000 | 28 | 150 | 0.9-j*1.0 | 3.1-j*3.4 | 49.50 | 16.19 | 77.73 |
| MXE | 2000 | 28 | 150 | 0.9-j*1.0 | 3.4-j*1.3 | 48.39 | 17.65 | 82.80 |
| Trade Off | 2000 | 28 | 150 | 0.9-j*1.0 | 3.4-j*2.1 | 49 | 17.16 | 81.37 |

NX6010H GaN TRANSISTOR

| NU6006H | Freq (MHz) | VDD (V) | ldq (mA) | Zsource (ohms) | Zload (ohms) | Pout (dBm) | Gain (dB) | Eff (%) |
|-----------|---------------|------------|-------------|-------------------|-----------------|---------------|--------------|------------|
| MXP | 2500 | 28 | 150 | 1.7-j*4.2 | 3.7-j*3.1 | 49.33 | 13.74 | 76.66 |
| MXE | 2500 | 28 | 150 | 1.7-j*4.2 | 3.0-j*0.7 | 48.01 | 14.75 | 82.18 |
| Trade Off | 2500 | 28 | 150 | 1.7-j*4.2 | 3.1-j*1.6 | 48.83 | 14.36 | 79.69 |

| NU6006H | Freq (MHz) | VDD (V) | ldq (mA) | Zsource (ohms) | Zload (ohms) | Pout (dBm) | Gain (dB) | Eff (%) |
|-----------|---------------|------------|-------------|-------------------|-----------------|---------------|--------------|------------|
| MXP | 3000 | 28 | 150 | 1.9-j*6.3 | 3.2-j*5.3 | 49.22 | 12.30 | 75.56 |
| MXE | 3000 | 28 | 150 | 1.9-j*6.3 | 2.4-j*3.7 | 48.18 | 12.87 | 80.05 |
| Trade Off | 3000 | 28 | 150 | 1.9-j*6.3 | 2.7-j*4.2 | 48.72 | 12.78 | 79.14 |

Package Outline



Document Number: NX6010H Preliminary Datasheet V1.2

Revision history

Table 4. Document revision history

| Date | Revision | Datasheet Status | | | |
|------------|-------------------------------------|--|--|--|--|
| 2018/10/26 | V1.0 Preliminary datasheet creation | | | | |
| 2018/11/13 | V1.1 | V1.1 Modify Gp and Psat, and add loadpull data | | | |
| 2022/9/19 | V1.2 | Modify the LBB Pkg drawing | | | |

Notice

Specifications are subject to change without notice. Innogration believes the information within the data sheet to be reliable. Innogration makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose.

"Typical" parameter is the average values expected by Innogration in quantities and are provided for information purposes only. It can and do vary in different applications and related performance can vary over time. All parameters should be validated by customer's technical experts for each application.

Innogration products are not designed, intended or authorized for use as components in applications intended for surgical implant into the body or to support or sustain life, in applications in which the failure of the Innogration product could result in personal injury or death or in applications for planning, construction, maintenance or direct operation of a nuclear facility.

For any concerns or questions related to terms or conditions, please check with Innogration and authorized distributors Copyright © by Innogration (Suzhou) Co.,Ltd.